STF35N60DM2



N-channel 600 V, 0.094 Ω typ., 28 A MDmesh[™] DM2 Power MOSFET in a TO-220FP package

Datasheet - production data



Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	ID	Ρτοτ
STF35N60DM2	600 V	0.110 Ω	28 A	40 W

- Fast-recovery body diode
- Extremely low gate charge and input capacitance
- Low on-resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

Applications

• Switching applications

Description

This high voltage N-channel Power MOSFET is part of the MDmeshTM DM2 fast recovery diode series. It offers very low recovery charge (Q_{rr}) and time (t_{rr}) combined with low $R_{DS(on)}$, rendering it suitable for the most demanding high efficiency converters and ideal for bridge topologies and ZVS phase-shift converters.

Table 1: Device summary

Order code	Marking	Package	Packing
STF35N60DM2	35N60DM2	TO-220FP	Tube

This is information on a product in full production.

Contents

Contents

1	Electric	al ratings	3
2	Electric	al characteristics	4
	2.1	Electrical characteristics (curves)	6
3	Test cir	cuits	8
4	Packag	e information	9
	4.1	TO-220FP package information	10
5	Revisio	n history	12



1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	±25	V
ا _D ⁽¹⁾	Drain current (continuous) at T _{case} = 25 °C	28	А
ID	Drain current (continuous) at T _{case} = 100 °C	17	A
I _{DM} ⁽²⁾	Drain current (pulsed)	112	А
P _{TOT}	Total dissipation at T _{case} = 25 °C	40	W
dv/dt ⁽³⁾	Peak diode recovery voltage slope	50	V/ns
dv/dt ⁽⁴⁾	MOSFET dv/dt ruggedness	50	V/115
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; T_c = 25 °C)	2.5	kV
T _{stg}	Storage temperature	-55 to	°C
Tj	Operating junction temperature	150	C

Notes:

⁽¹⁾ Limited by maximum junction temperature.

 $^{\left(2\right) }$ Pulse width is limited by safe operating area.

 $^{(3)}$ I_SD ≤ 28 A, di/dt=900 A/µs; V_Ds peak < V_{(BR)DSS}, V_{DD} = 400 V

⁽⁴⁾ $V_{DS} \le 480 \text{ V}.$

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case	3.1	°C/W
R _{thj-amb}	Thermal resistance junction-amb	62.5	C/VV

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive	6	А
E _{AS} ⁽¹⁾	Single pulse avalanche energy	650	mJ

Notes:

 $^{(1)}$ starting T_{j} = 25 °C, I_{D} = $I_{AR},\,V_{DD}$ = 50 V.



2 Electrical characteristics

 $(T_{case} = 25 \text{ °C unless otherwise specified})$

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 V, I_D = 1 mA$	600			V
	Zoro goto voltago droin	$V_{GS} = 0 V, V_{DS} = 600 V$			10	
I _{DSS}	Zero gate voltage drain current	$V_{GS} = 0 V$, $V_{DS} = 600 V$, $T_{case} = 125 $ °C			100	μA
I _{GSS}	Gate-body leakage current	$V_{DS} = 0 V, V_{GS} = \pm 25 V$			±5	μA
V _{GS(th)}	Gate threshold voltage	V_{DS} = V_{GS} , I_D = 250 μ A	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	$V_{GS} = 10 \text{ V}, I_D = 14 \text{ A}$		0.094	0.11	Ω

Table 6: Dynamic						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	2400	-	
C _{oss}	Output capacitance	$V_{\text{DS}} = 100 \text{ V}, \text{ f} = 1 \text{ MHz}, \text{ V}_{\text{GS}} = 0 \text{ V}$	-	110	-	pF
Crss	Reverse transfer capacitance		-	2.8	-	
Coss eq. ⁽¹⁾	Equivalent output capacitance	$V_{DS} = 0$ to 480 V, $V_{GS} = 0$ V	-	190	-	pF
R _G	Intrinsic gate resistance	$f = 1 \text{ MHz}, I_D = 0 \text{ A}$	-	4.3	-	Ω
Qg	Total gate charge		-	54	-	
Q _{gs}	Gate-source charge	V_{DD} = 480 V, I_D = 28 A, V_{GS} = 10 V (see Figure 15: "Test circuit for gate charge behavior")	-	14.6	-	nC
Q _{gd}	Gate-drain charge		-	24.2	-	

Notes:

 $^{(1)}$ $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS} .



Electrical characteristics

	Table 7: Switching times						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
t _{d(on)}	Turn-on delay time	$V_{\rm ex} = 300 V_{\rm ex} = 14.0 P_{\rm e} = 4.7 O_{\rm ex}$	-	21.2	-		
tr	Rise time	$V_{DD} = 300 \text{ V}, I_D = 14 \text{ A } R_G = 4.7 \Omega,$ $V_{GS} = 10 \text{ V}$ (see <i>Figure 14: "Test circuit for</i>	-	17	-		
t _{d(off)}	Turn-off delay time	resistive load switching times" and Figure 19: "Switching time waveform")	-	68	-	ns	
t _f	Fall time		-	10.7	-		

Table	8:	Source-drain	diode
	•••		

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		28	А
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		112	A
V _{SD} ⁽²⁾	Forward on voltage	$V_{GS} = 0 V, I_{SD} = 28 A$	-		1.6	V
t _{rr}	Reverse recovery time		-	120		ns
Q _{rr}	Reverse recovery charge	$I_{SD} = 28 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, V_{DD} = 60 \text{ V}$ (see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	572		nC
I _{RRM}	Reverse recovery current		-	10.2		A
t _{rr}	Reverse recovery time		-	215		ns
Q _{rr}	Reverse recovery charge	I_{SD} = 28 A, di/dt = 100 A/µs, V _{DD} = 60 V, T _j = 150 °C (see <i>Figure 16: "Test circuit for</i> <i>inductive load switching and diode</i>	-	1.89		μC
I _{RRM}	Reverse recovery current	recovery times")	-	17.7		А

Notes:

 $^{\left(1\right) }$ Pulse width is limited by safe operating area.

 $^{(2)}$ Pulse test: pulse duration = 300 $\mu s,$ duty cycle 1.5%.

Table 9: Gate-source Zene	diode
---------------------------	-------

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)GSO}	Gate-source breakdown voltage	$I_{GS} = \pm 250 \ \mu A, I_D = 0 \ A$	±30	-	-	V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.











Electrical characteristics







57

3 Test circuits









4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.



4.1 TO-220FP package information





STF35N60DM2

Package information

DM2			Package information					
Table 10: TO-220FP package mechanical data								
Dim	mm							
Dim.	Min.	Тур.	Max.					
А	4.4		4.6					
В	2.5		2.7					
D	2.5		2.75					
E	0.45		0.7					
F	0.75		1					
F1	1.15		1.70					
F2	1.15		1.70					
G	4.95		5.2					
G1	2.4		2.7					
Н	10		10.4					
L2		16						
L3	28.6		30.6					
L4	9.8		10.6					
L5	2.9		3.6					
L6	15.9		16.4					
L7	9		9.3					
Dia	3		3.2					



5 Revision history

Table 11: Document revision history

Date	Revision	Changes
15-Sep-2015	1	Initial version



STF35N60DM2

IMPORTANT NOTICE - PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2015 STMicroelectronics - All rights reserved

